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# High Speed, High Gain Bipolar NPN Transistor Integrating an Antisaturation Network and a Transient Voltage Suppression Capability

The BUL42D is a state-of-the-art bipolar transistor. Tight dynamic characteristics and lot to lot minimum spread make it ideally suitable for light ballast applications.

#### Main Features:

- Free Wheeling Diode Built In
- Flat DC Current Gain
- Fast Switching Times and Tight Distribution
- "Six Sigma" Process Providing Tight and Reproducible Parameter Spreads

#### **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector-Emitter Sustaining Voltage	V <sub>CEO</sub>	400	Vdc
Collector-Base Breakdown Voltage	V <sub>CBO</sub>	700	Vdc
Collector-Emitter Breakdown Voltage	V <sub>CES</sub>	700	Vdc
Emitter-Base Voltage	V <sub>EBO</sub>	9	Vdc
Collector Current – Continuous – Peak (Note 1)	I <sub>C</sub>	4.0 8.0	Adc
Base Current - Continuous - Peak (Note 1)	I <sub>B</sub>	1.0 2.0	Adc
*Total Device Dissipation @ T <sub>C</sub> = 25°C *Derate above 25°C	P <sub>D</sub>	75 0.6	Watt W/°C
Operating and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	-65 to +150	°C

#### **TYPICAL GAIN**

Typical Gain @ I <sub>C</sub> = 1 A, V <sub>CE</sub> = 2 V	h <sub>FE</sub>	13	-
Typical Gain @ $I_C = 0.3 A$ , $V_{CE} = 1 V$	h <sub>FE</sub>	16	-

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance – Junction–to–Case	$R_{\theta JC}$	1.66	°C/W
Thermal Resistance – Junction–to–Ambient	$R_{\theta JA}$	62.5	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 seconds	T <sub>L</sub>	260	°C

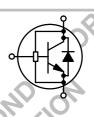
<sup>1.</sup> Pulse Test: Pulse Width = 5.0 ms, Duty Cycle = 10%

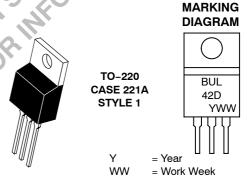


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### 4 AMPERES 700 VOLTS, 75 WATTS POWER TRANSISTOR





#### **ORDERING INFORMATION**

Device	Package	Shipping
BUL42D	TO-220	50 Units/Rail

### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

	Characteristic			Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•				
Collector–Emitter Sustaining Voltage (I <sub>C</sub> = 100 mA, L = 25 mH)			V <sub>CEO(sus)</sub>	400	430	-	Vdc	
Collector-Base Breakdown Voltage (I <sub>CBO</sub> = 1 mA)			V <sub>CBO</sub>	700	780	-	Vdc	
Emitter-Base Breakdown Voltage (I <sub>EBO</sub> = 1 mA)			V <sub>EBO</sub>	9.0	12	-	Vdc	
Collector Cutoff Current (V <sub>CE</sub> = Rated V <sub>CEO</sub> , I <sub>B</sub>	Collector Cutoff Current $@ T_C = 25^{\circ}C$ $(V_{CE} = Rated V_{CEO}, I_B = 0)$ $@ T_C = 125^{\circ}C$			I <sub>CEO</sub>	- -	- -	100 200	μAdc
Collector Cutoff Current (V <sub>CE</sub> = Rated V <sub>CES</sub> , V <sub>EB</sub> =	= 0)		@ T <sub>C</sub> = 25°C @ T <sub>C</sub> = 125°C	I <sub>CES</sub>	-	- -	10 200	μAdc
Emitter-Cutoff Current (V <sub>EB</sub> = 9 Vdc, I <sub>C</sub> = 0)			I <sub>EBO</sub>	-	-	100	μAdc	
ON CHARACTERISTICS								
Base–Emitter Saturation \( (I <sub>C</sub> = 1 Adc, I <sub>B</sub> = 0.2 Add	•			V <sub>BE(sat)</sub>	-	0.85	1.2	Vdc
Collector–Emitter Saturation Voltage (I <sub>C</sub> = 2 Adc, I <sub>B</sub> = 0.5 Adc)			V <sub>CE(sat)</sub>	=	0.2	1.0	Vdc	
DC Current Gain $(I_C = 1 \text{ Adc}, V_{CE} = 2 \text{ Vdc})$ $(I_C = 2 \text{ Adc}, V_{CE} = 5 \text{ Vdc})$			h <sub>FE</sub>	8.0 10	13 12	1 1	-	
DIODE CHARACTERISTIC	s							
Forward Diode Voltage (I <sub>EC</sub> = 1.0 Adc)			V <sub>EC</sub>	-	0.9	1.5	V	
SWITCHING CHARACTER	ISTICS: Resistive I	oad (D.C.	≤ 10%, Pulse Width	n = 40 μs)				
Turn-Off Time ( $I_C = 1.2 \text{ Adc}, I_{B1} = 0.4 \text{ A}, I_{B2} = 0.1 \text{ A}, V_{CC} = 300 \text{ V}$ )			T <sub>off</sub>	4.6	-	6.55	μs	
Fall Time ( $I_C = 2.5 \text{ Adc}, I_{B1} = I_{B2} = 0.5 \text{ A}, V_{CC} = 150 \text{ V}, V_{BE} = -2 \text{ V}$ )			T <sub>f</sub>	-	-	0.8	μS	
DYNAMIC SATURATION V	OLTAGE							
Dynamic Saturation Voltage: Determined 1 μs and	I <sub>C</sub> = 400 mA I <sub>B1</sub> = 40 mA	@ 1 μs	@ T <sub>C</sub> = 25°C @ T <sub>C</sub> = 125°C	VCE(dsat)	- -	2.8 3.2	- -	V
		@ 3 μs	@ T <sub>C</sub> = 25°C @ T <sub>C</sub> = 125°C		- -	0.75 1.3	- -	
3 μs respectively after rising I <sub>B1</sub> reaches	y after @ 1 μs	@ 1 μs	@ T <sub>C</sub> = 25°C @ T <sub>C</sub> = 125°C		- -	2.1 4.7	- -	
90% of final I <sub>B1</sub>		@ 3 μs	@ T <sub>C</sub> = 25°C @ T <sub>C</sub> = 125°C		- -	0.35 0.6	_ _	

#### TYPICAL STATIC CHARACTERISTICS

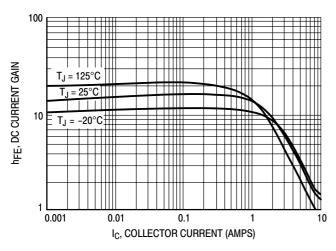


Figure 1. DC Current Gain @ V<sub>CE</sub> = 1 V

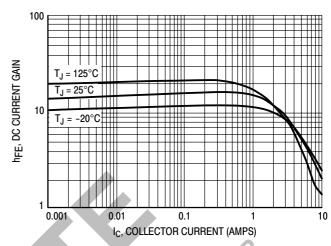


Figure 2. DC Current Gain @ V<sub>CE</sub> = 5 V

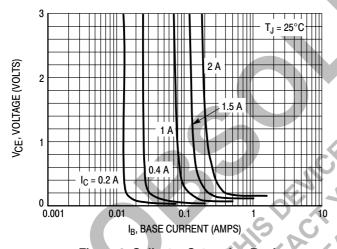


Figure 3. Collector Saturation Region

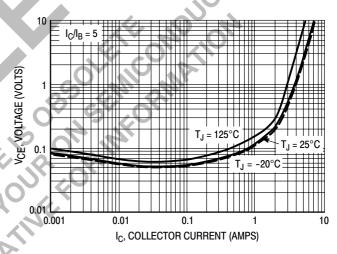


Figure 4. Collector-Emitter Saturation Voltage

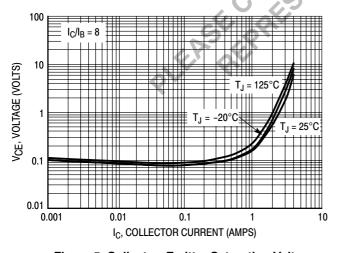


Figure 5. Collector-Emitter Saturation Voltage

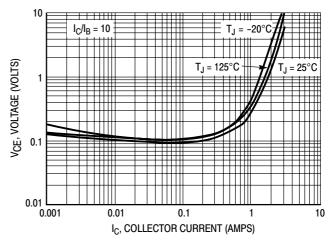


Figure 6. Collector-Emitter Saturation Voltage

#### TYPICAL STATIC CHARACTERISTICS

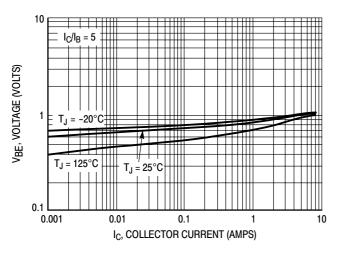


Figure 7. Base-Emitter Saturation Region

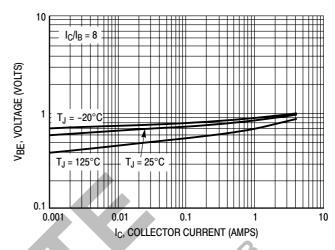


Figure 8. Base-Emitter Saturation Region

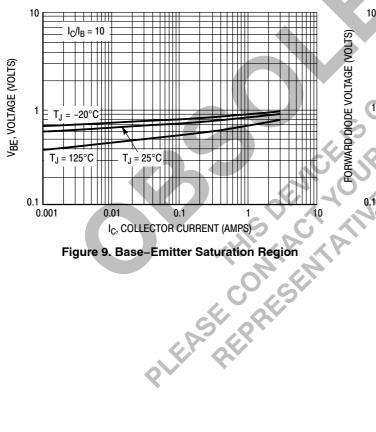


Figure 9. Base-Emitter Saturation Region

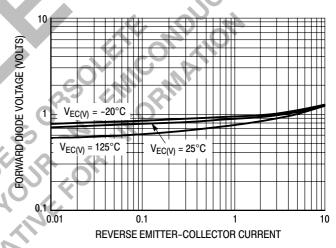


Figure 10. Forward Diode Voltage

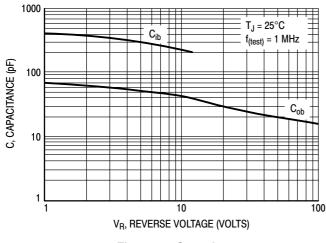


Figure 11. Capacitance

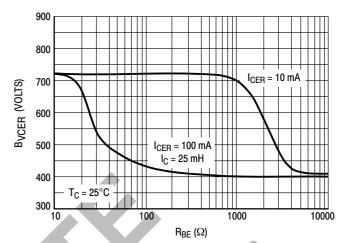
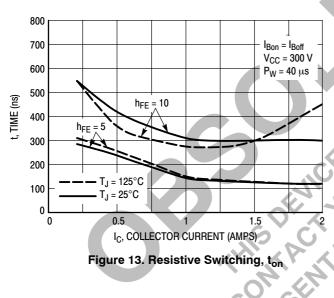


Figure 12.  $B_{VCER} = f(R_{BE})$ 



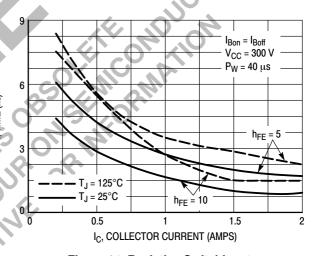


Figure 14. Resistive Switching, toff

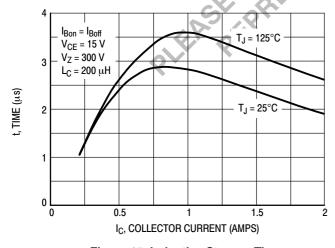


Figure 15. Inductive Storage Time, t<sub>si</sub> @ h<sub>FE</sub> = 5

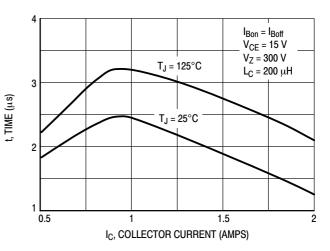


Figure 16. Inductive Storage Time, t<sub>si</sub> @ h<sub>FE</sub> = 10

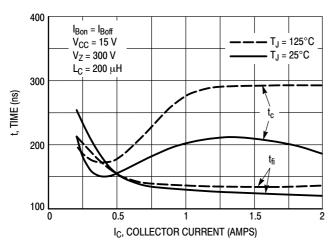


Figure 17. Inductive Fall and Cross Over Time,  $t_{\rm fi}$  and  $t_{\rm c}$  @  $h_{\rm FE}$  = 5

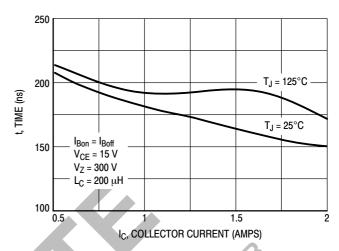


Figure 18. Inductive Fall Time, t<sub>fi</sub> @ h<sub>FE</sub> = 10

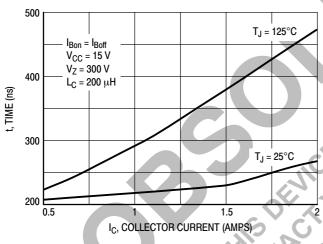


Figure 19. Inductive Cross Over Time,  $t_c @ h_{FE} = 10$ 

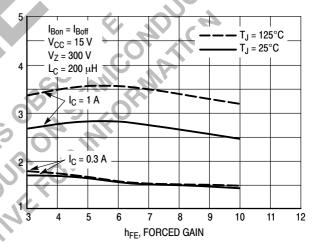


Figure 20. Inductive Storage Time, tsi

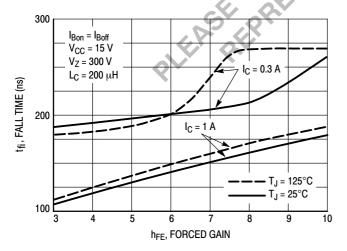


Figure 21. Inductive Fall Time, tf

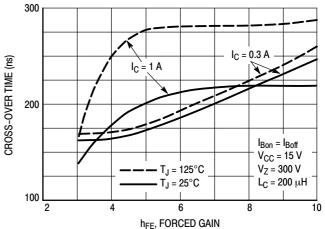


Figure 22. Inductive Cross Over Time, tc

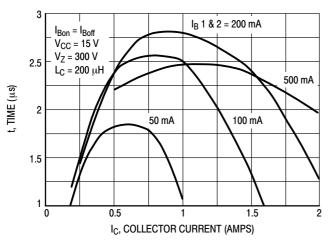


Figure 23. Inductive Storage Time, tsi

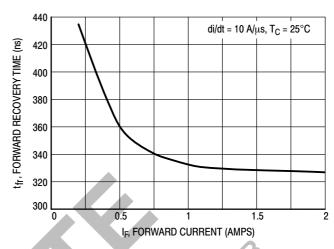
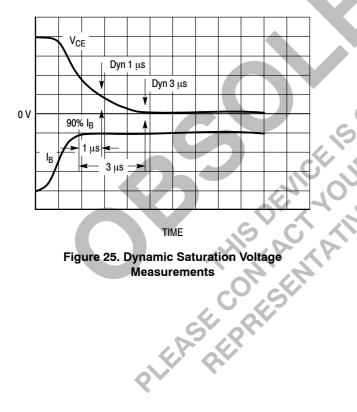


Figure 24. Forward Recovery Time, tfr



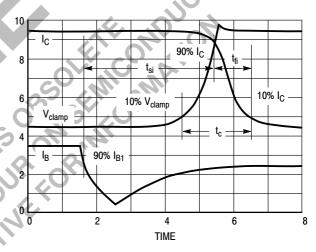
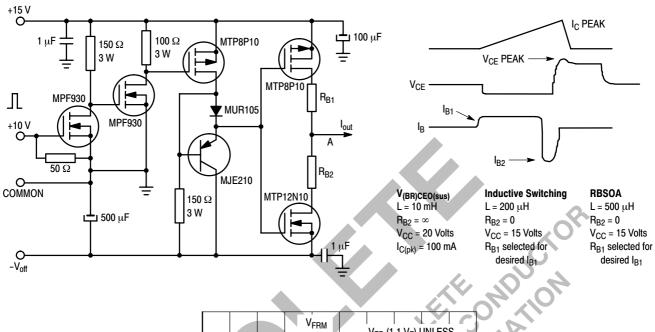
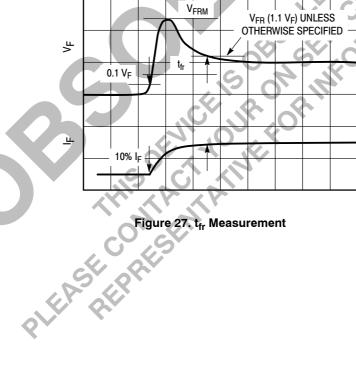


Figure 26. Inductive Switching Measurements

**Table 1. Inductive Load Switching Drive Circuit** 





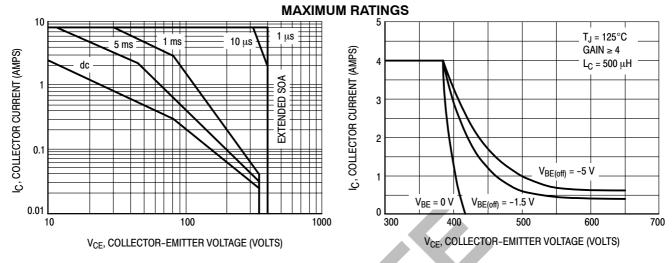
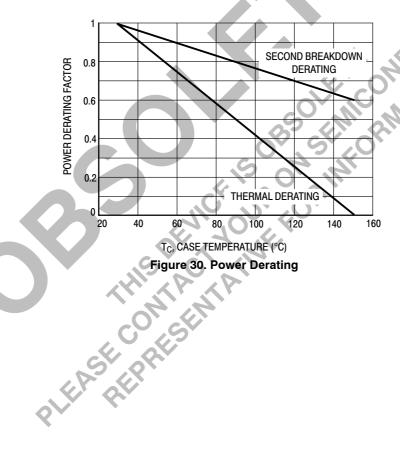


Figure 28. Forward Bias Safe Operating Area

Figure 29. Reverse Bias Safe Operating Area



There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I<sub>C</sub>-V<sub>CE</sub> limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 28 is based on  $T_C = 25$ °C;  $T_{j(pk)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C > 25$ °C. Second Breakdown limitations do not derate like thermal limitations. Allowable current at the voltages shown on Figure 28 may be found at any case temperature by using the appropriate curve on Figure 30.

T<sub>i(pk)</sub> may be calculated from the data in Figure 31. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base to emitter junction reverse biased. The safe level is specified as reverse biased safe operating area (Figure 29). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

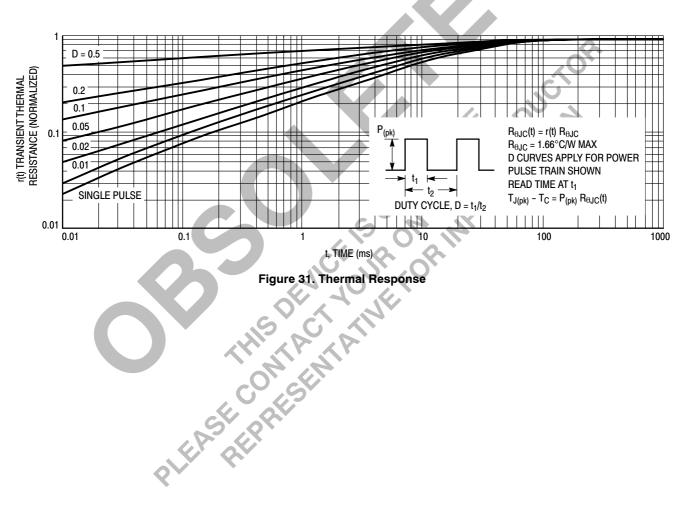
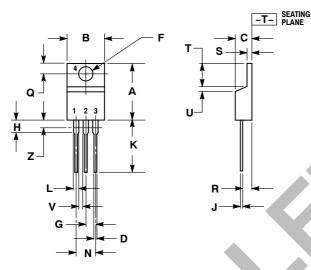


Figure 31. Thermal Response

#### PACKAGE DIMENSIONS

#### TO-220 CASE 221A-09 **ISSUE AA**



#### NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14 5M 1982
- CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
B	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T₄	0.235	0.255	5.97	6.47
J	0.000	0.050	0.00	1.27
٧	0.045	<u></u>	1.15	
Z		0.080	<b>/</b> -	2.04

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